# **8SLVP1212**

### Low Phase Noise, 1-to-12, 3.3V, 2.5V RENESAS LVPECL Output Fanout Buffer

## **DATASHEET**

## **Description**

The 8SLVP1212 is a high-performance, 12 output differential LVPECL fanout buffer. The device is designed for the fanout of high-frequency, very low additive phase-noise clock and data signals. The 8SLVP1212 is characterized to operate from a 3.3V and 2.5V power supply. Guaranteed output-to-output and part-to-part skew characteristics make the 8SLVP1212 ideal for those clock distribution applications demanding well-defined performance and repeatability. Two selectable differential inputs and twelve low skew outputs are available. The integrated bias voltage generators enables easy interfacing of single-ended signals to the device inputs. The device is optimized for low power consumption and low additive phase noise.

## **Block Diagram**



## **Features**

- **•** Twelve low skew, low additive jitter LVPECL outputs
- **•** Two selectable, differential clock inputs
- **•** Differential pairs can accept the following differential input levels: LVDS, LVPECL, CML
- **•** Maximum input clock frequency: 2GHz
- **•** LVCMOS interface levels for the control input (input select)
- **•** Output skew: 33ps (maximum)
- **•** Propagation delay: 550ps (maximum)
- Low additive phase jitter, RMS at  $f_{REF}$  = 156.25MHz, V<sub>PP</sub> = 1V, 12kHz–20MHz: 60fs (maximum)
- **•** Full 3.3V and 2.5V supply voltage
- Device current consumption (I<sub>FF</sub>): 131mA (maximum)
- **•** Available in Lead-free (RoHS 6), 40-VFQFPN package
- **•** -40°C to +85°C ambient operating temperature
- **•** Differential PCLK0, nPCLK0 and PCLK1, nPCLK1 pairs can also accept single-ended LVCMOS levels. See Applications section Wiring the Differential Input Levels to Accept Single-ended Levels (Figure 1A and Figure 1B)
- **•** Supports PCI Express Gen1–5

# **Pin Assignment**



# **Table 1. Pin Descriptions**



NOTE: *Pulldown* and *Pullup* refers to an internal input resistors. See Table 2, *Pin Characteristics,* for typical values.

## **Table 2. Pin Characteristics**



# **Function Table**

#### **Table 3. SEL Input Section Function Table**



NOTE: SEL is an asynchronous control.

# **Absolute Maximum Ratings**

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of the product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.



NOTE 1: According to JEDEC/JESD 22-A114/22-C101. ESD ratings are target specifications.

# **DC Electrical Characteristics**

**Table 4A. Power Supply DC Characteristics,**  $V_{CC} = 3.3V \pm 5\%$ ,  $V_{EE} = 0V$ ,  $T_A = -40^{\circ}C$  to 85°C



## **Table 4B. Power Supply DC Characteristics,**  $V_{CC} = 2.5V \pm 5\%$ ,  $V_{EE} = 0V$ ,  $T_A = -40^{\circ}C$  to 85°C



## **Table 4C. LVCMOS/LVTTL DC Characteristics,**  $V_{CC} = 3.3V \pm 5\%$  or  $2.5V \pm 5\%$ ,  $V_{EE} = 0V$ ,  $T_A = -40^{\circ}C$  to  $85^{\circ}C$





#### **Table 4D. LVPECL DC Characteristics,**  $V_{CC} = 3.3V + 5\%$ ,  $V_{CC} = 0V$ ,  $T_A = -40\degree$ C to 85 $\degree$ C.

NOTE: Input and output parameters vary 1:1 with  $V_{CC}$ .

NOTE 1: V<sub>REF</sub> is for 3.3V±5% V<sub>CC</sub> only. To obtain a bias voltage for V<sub>CC</sub> = 2.5V±5% application, an external voltage supply is recommended. NOTE 2: Outputs terminated with 50 $\Omega$  to  $V_{CC}$  – 2V.

**Table 4E. LVPECL DC Characteristics,**  $V_{CC} = 2.5V \pm 5\%$ ,  $V_{EE} = 0V$ ,  $T_A = -40^{\circ}C$  to 85°C

Symbol	<b>Parameter</b>		<b>Test Conditions</b>	<b>Minimum</b>	<b>Typical</b>	<b>Maximum</b>	<b>Units</b>
$I_{\text{IH}}$	Input High Current	PCLK0, nPCLK0 PCLK1, nPCLK1	$V_{CC}$ = $V_{IN}$ = 2.625V			150	μA
$I_{IL}$	Input Low Current	PCLK0, PCLK1	$V_{CC}$ = 2.625V, $V_{IN}$ = 0V	$-10$			μA
		nPCLK0, nPCLK1	$V_{CC}$ = 2.625V, $V_{IN}$ = 0V	$-150$			μA
$V_{REF}$	Reference Voltage for Input Bias: NOTE 1		$I_{REF}$ = 2mA	$V_{\rm CC}$ – 1.6	$V_{\rm CC}$ – 1.26	$V_{\rm CC}$ – 1.1	V
$V_{OH}$	Output High Voltage; NOTE 2			$V_{\rm CC}$ – 1.26	$V_{\rm CC}$ – 0.84	$V_{\rm CC}$ – 0.6	V
$V_{OL}$	Output Low Voltage; NOTE 2			$V_{\rm CC}$ – 1.7	$V_{\rm CC}$ – 1.47	$V_{\rm CC}$ – 1.28	V

NOTE: Input and output parameters vary 1:1 with  $V_{CC}$ .

NOTE 1: V<sub>REF</sub> is for 3.3V±5% V<sub>CC</sub> only. To obtain a bias voltage for V<sub>CC</sub> = 2.5V±5% application, an external voltage supply is recommended. NOTE 2: Outputs terminated with  $50\Omega$  to V<sub>CC</sub> – 2V.

# **AC Electrical Characteristics**

**Table 5. AC Electrical Characteristics,**  $V_{CC}$  = 3.3V  $\pm$  5% or 2.5V  $\pm$  5%,  $V_{EE}$  = 0V,  $T_A$  = -40°C to 85°C



*NOTES on next page.*



NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 1: Measured from the differential input crosspoint to the differential output crosspoint.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential crosspoints. NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.

NOTE 4: Defined as skew between outputs on different devices operating at the same supply voltage, same frequency, same temperature and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential crosspoints.

NOTE 5:  $V_{II}$  should not be less than -0.3V.  $V_{IH}$  should not be higher than  $V_{CC}$ .

NOTE 6: Common mode input voltage is defined at the crosspoint.

NOTE 7: For single-ended LVCMOS input applications, please refer to the Applications Information, Wiring the Differential Input to accept single-ended levels, Figures 1A and 1B.

# **Additive Phase Jitter (3.3V at 122.88MHz)**

The spectral purity in a band at a specific offset from the fundamental compared to the power of the fundamental is called the *dBc Phase Noise.* This value is normally expressed using a Phase noise plot and is most often the specified plot in many applications. Phase noise is defined as the ratio of the noise power present in a 1Hz band at a specified offset from the fundamental frequency to the power value of the fundamental. This ratio is expressed in decibels (dBm) or a ratio

of the power in the 1Hz band to the power in the fundamental. When the required offset is specified, the phase noise is called a *dBc* value, which simply means dBm at a specified offset from the fundamental. By investigating jitter in the frequency domain, we get a better understanding of its effects on the desired application over the entire time record of the signal. It is mathematically possible to calculate an expected bit error rate given a phase noise plot.



Offset from Carrier Frequency (Hz)

As with most timing specifications, phase noise measurements have issues relating to the limitations of the measurement equipment. The noise floor of the equipment can be higher or lower than the noise floor of the device. Additive phase noise is dependent on both the noise floor of the input source and measurement equipment.

Measured using a Wenzel 122.88MHz Oscillator as the input source.

# **Additive Phase Jitter (3.3V at 156.25MHz)**

The spectral purity in a band at a specific offset from the fundamental compared to the power of the fundamental is called the *dBc Phase Noise.* This value is normally expressed using a Phase noise plot and is most often the specified plot in many applications. Phase noise is defined as the ratio of the noise power present in a 1Hz band at a specified offset from the fundamental frequency to the power value of the fundamental. This ratio is expressed in decibels (dBm) or a ratio

of the power in the 1Hz band to the power in the fundamental. When the required offset is specified, the phase noise is called a *dBc* value, which simply means dBm at a specified offset from the fundamental. By investigating jitter in the frequency domain, we get a better understanding of its effects on the desired application over the entire time record of the signal. It is mathematically possible to calculate an expected bit error rate given a phase noise plot.



As with most timing specifications, phase noise measurements have issues relating to the limitations of the measurement equipment. The noise floor of the equipment can be higher or lower than the noise floor of the device. Additive phase noise is dependent on both the noise floor of the input source and measurement equipment.

Measured using a Wenzel 156.25MHz Oscillator as the input source.

## **Parameter Measurement Information**



**3.3V LVPECL Output Load AC Test Circuit**



**Differential Input Level**



**Part-to-Part Skew**



**2.5V LVPECL Output Load AC Test Circuit**









# **Parameter Measurement Information, continued**









**Propagation Delay**



**MUX Isolation**

**Output Voltage Swing**

# **Applications Information**

## **Wiring the Differential Input to Accept Single-Ended Levels**

The 8SLVP1212 inputs can be interfaced to LVPECL, LVDS, CML or LVCMOS drivers. *Figure 1A* illustrates how to dc couple a single LVCMOS input to the 8SLVP1212. The value of the series resistance RS is calculated as the difference between the transmission line impedance and the driver output impedance. This resistor should be placed close to the LVCMOS driver. To avoid cross-coupling of single-ended LVCMOS signals, apply the LVCMOS signals to no more than one PCLK input.

A practical method to implement Vth is shown in *Figure 1B* below. The reference voltage Vth = V1 =  $V_{CC}/2$ , is generated by the bias resistors R1 and R2. The bypass capacitor (C1) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible.

The ratio of R1 and R2 might need to be adjusted to position the V1 in the center of the input voltage swing. For example, if the input clock swing is 2.5V and  $V_{CC}$  = 3.3V, R1 and R2 value should be adjusted to set V1 at 1.25V. The values below apply when both the to set virial 1.25v. The values below apply when bout the<br>single-ended swing and V<sub>CC</sub> are at the same voltage.<br>**COLLIDAGE** 

When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMOS signaling, it is recommended that the amplitude be reduced, particularly if both input references are LVCMOS to minimize cross talk. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however  $V_{\text{II}}$ cannot be less than -0.3V and  $V_{H}$  cannot be more than  $V_{CC}$  + 0.3V.

Figure 1B shows a way to attenuate the PCLK input level by a factor of two as well as matching the transmission line between the LVCMOS driver and the IDT8SLVP1212I at both the source and the



# **8SLVP1212**

load. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. R3 and R4 in parallel should equal the transmission line impedance; for most  $50\Omega$  applications, R3 and R4 will be 100 $\Omega$ . The values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver.

Though some of the recommended components of Figure 1B might not be used, the pads should be placed in the layout so that they can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.



**Figure 1B. Alternative DC Coupling a Single LVCMOS Input to the 8SLVP1212**

## **Recommendations for Unused Input and Output Pins**

#### **Inputs:**

#### **PCLKx/nPCLKx Inputs**

For applications not requiring the use of a differential input, both the PCLKx and nPCLKx pins can be left floating. Though not required, but for additional protection, a 1k $\Omega$  resistor can be tied from PCLKx to ground. For applications

### **Outputs:**

#### **LVPECL Outputs**

All unused LVPECL outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

## **3.3V LVPECL Clock Input Interface**

The PCLK /nPCLK accepts LVPECL, LVDS, CML and other differential signals. Both differential outputs must meet the  $V_{PP}$  and V<sub>CMR</sub> input requirements. *Figures 2A to 2E* show interface examples for the PCLK/ nPCLK input driven by the most common driver types. The input interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.



**Figure 2A. PCLK/nPCLK Input Driven by a CML Driver**



**Figure 2C. PCLK/nPCLK Input Driven by a 3.3V LVPECL Driver**







**Figure 2B. PCLK/nPCLK Input Driven by a Built-In Pullup CML Driver**



**Figure 2D. PCLK/nPCLK Input Driven by a 3.3V LVPECL Driver with AC Couple**

## **2.5V LVPECL Clock Input Interface**

The PCLK /nPCLK accepts LVPECL, LVDS, CML and other differential signals. Both differential outputs must meet the  $V_{\text{PP}}$  and V<sub>CMR</sub> input requirements. *Figures 3A to 3E* show interface examples for the PCLK/ nPCLK input driven by the most common driver types.



**Figure 3A. PCLK/nPCLK Input Driven by a CML Driver**



**Figure 3C. PCLK/nPCLK Input Driven by a 2.5V LVPECL Driver**





The input interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.



**Figure 3B. PCLK/nPCLK Input Driven by a Built-In Pullup CML Driver**



**Figure 3D. PCLK/nPCLK Input Driven by a 2.5V LVPECL Driver with AC Couple**

## **VFQFN EPAD Thermal Release Path**

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in *Figure 4.* The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/ Electrically Enhance Leadframe Base Package, Amkor Technology.



**Figure 4. P.C. Assembly for Exposed Pad Thermal Release Path – Side View (drawing not to scale)**

## **Termination for 3.3V LVPECL Outputs**

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential outputs are a low impedance follower output that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive  $50\Omega$ 



**Figure 5A. 3.3V LVPECL Output Termination Figure 5B. 3.3V LVPECL Output Termination**

transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. *Figures 5A and 5B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.



 $V_{\text{CC}} = 2.5V$ 

 $V_{\text{CC}} = 2.5V$ 2.5V

50

50

**Figure 6C. 2.5V LVPECL Driver Termination Example**

# **Termination for 2.5V LVPECL Outputs**

*Figure 6A* and *Figure 6B* show examples of termination for 2.5V LVPECL driver. These terminations are equivalent to terminating  $50\Omega$ to  $V_{CC}$  – 2V. For  $V_{CC}$  = 2.5V, the  $V_{CC}$  – 2V is very close to ground

2.5V

R3 250

R1 250 2.5V

+

–







**Figure 6B. 2.5V LVPECL Driver Termination Example**

level. The R3 in Figure 6B can be eliminated and the termination is shown in *Figure 6C.*

## <span id="page-17-0"></span>**Termination for Q, nQ LVPECL Outputs AC-Coupled into HCSL-Receiver**



**Figure 7. LVPECL Output AC-Coupled into HCSL Receiver**

#### **Table 6. Termination Resistors**



#### **Table 7. HCSL Receiver Voltage Bias**



## **Power Considerations**

This section provides information on power dissipation and junction temperature for the 8SLVP1212. Equations and example calculations are also provided.

#### **1. Power Dissipation.**

The total power dissipation for the 8SLVP1212 is the sum of the core power plus the power dissipation in the load(s). The following is the power dissipation for  $V_{CC}$  = 3.3V + 5% = 3.465V, which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipation in the load.

- Power (core)<sub>MAX</sub> =  $V_{\text{CC\_MAX}}$  \*  $I_{\text{EE\_MAX}}$  = 3.465V \* 131mA = 453.9mW
- Power (outputs)<sub>MAX</sub> = 35.2mW/Loaded Output pair If all outputs are loaded, the total power is 12 \* 35.2mW = **422.4mW**

**Total Power**<sub>\_MAX</sub> (3.465V, with all outputs switching) =  $453.9$ mW +  $422.4$ mW =  $876.3$ mW

#### **2. Junction Temperature.**

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad, and directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj =  $\theta_{JA}$  \* Pd\_total + T<sub>A</sub>

Tj = Junction Temperature

 $\theta_{JA}$  = Junction-to-Ambient Thermal Resistance

Pd\_total = Total Device Power Dissipation (example calculation is in section 1 above)

 $T_A$  = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance  $\theta_{JA}$  must be used. Assuming no air flow and a multi-layer board, the appropriate value is 38.1°C/W per Table 6 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

85°C + 0.876W  $*$  38.1°C/W = 118.4°C. This is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

#### Table 8. Thermal Resistance  $\theta_{JA}$  for a 40-Lead VFQFN



#### **3. Calculations and Equations.**

The purpose of this section is to calculate the power dissipation for the LVPECL output pair.

The LVPECL output driver circuit and termination are shown in *Figure 8.*



**Figure 8. LVPECL Driver Circuit and Termination**

To calculate power dissipation per output pair due to loading, use the following equations which assume a 50 $\Omega$  load, and a termination voltage of  $V_{CC} - 2V$ .

- For logic high,  $V_{\text{OUT}} = V_{\text{OH MAX}} = V_{\text{CC MAX}} 0.6V$  $(V_{\text{CC\_MAX}} - V_{\text{OH\_MAX}}) = 0.6V$
- For logic low,  $V_{\text{OUT}} = V_{\text{OL\_MAX}} = V_{\text{CC\_MAX}} 1.28V$  $(V_{CC~MAX} - V_{OL~MAX}) = 1.28V$

Pd\_H is power dissipation when the output drives high.

Pd\_L is the power dissipation when the output drives low.

 $Pd_H = [(V_{OH_MAX} - (V_{CC_MAX} - 2V))/R_L]^* (V_{CC_MAX} - V_{OH_MAX}) = [(2V - (V_{CC_MAX} - V_{OH_MAX}))/R_L]^* (V_{CC_MAX} - V_{OH_MAX}) =$  $[(2V – 0.6V)/50 $\Omega$ ] * 0.6V = 16.8mW$ 

 $Pd_L = [(V_{OL\_MAX} - (V_{CC\_MAX} - 2V))/R_L]^* (V_{CC\_MAX} - V_{OL\_MAX}) = [(2V - (V_{CC\_MAX} - V_{OL\_MAX}))/R_L]^* (V_{CC\_MAX} - V_{OL\_MAX}) =$  $[(2V – 1.28V)/50 $\Omega$ ] * 1.28V = 18.4mW$ 

Total Power Dissipation per output pair = Pd\_H + Pd\_L = **35.2mW**

## **Reliability Information**

Table 9.  $\theta_{JA}$  vs. Air Flow Table for a 40-VFQFPN



## **Transistor Count**

The transistor count for the 8SLVP1212 is: 7748

## **Package Outline Drawings**

The package outline drawings are located at the end of this document and are accessible from the Renesas website (see [Ordering Information](#page-20-0) for POD links). The package information is the most current data available and is subject to change without revision of this document.

## <span id="page-20-0"></span>**Ordering Information**

#### **Table 10. Ordering Information**



#### **Table 11. Pin 1 Orientation in Tape and Reel Packaging**



# **Revision History Sheet**





## **Package Outline Drawing**

Package Code:NLG40P1 40-VFQFPN 6.0 x 6.0 x 0.9 mm Body, 0.5mm Pitch PSC-4115-01, Revision: 01, Date Created: Nov 10, 2022

